

# Issue Classification



Application/Control No.

10712324

Applicant(s)/Patent under Reexamination

RIEL ET AL.

Examiner

Stephenson, Daniel P

Art Unit

3672

## ORIGINAL

CLASS

175

SUBCLASS

320

## CROSS REFERENCE(S)

CLASS

175

SUBCLASS (ONE SUBCLASS PER BLOCK)

57

## INTERNATIONAL CLASSIFICATION

CLAIMED

21 / 12

NON-CLAIMED

*David Bagnell*  
(Assistant Examiner)

6/22/06  
(Date)

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Total Claims Allowed:  
19

*Jeffrey*  
(Legal Instruments Examiner)

6/23/06  
(Date)

*David Bagnell*  
(Primary Examiner)

6/23/06  
(Date)

O.G.  
Print Claim(s)  
16

O.G.  
Print Figure  
4A